



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AON7380**

**30V N-Channel AlphaMOS**

### General Description

- Trench Power AlphaMOS ( $\alpha$ MOS LV) technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

### Product Summary

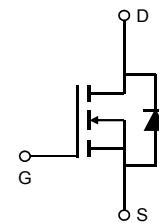
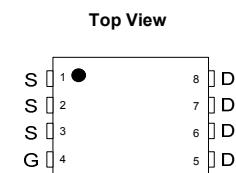
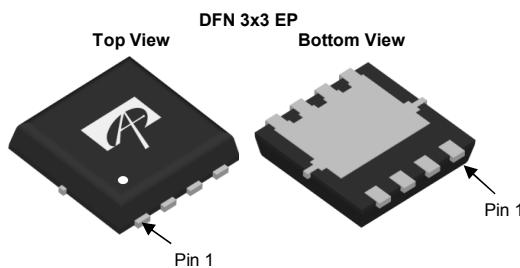
|                                  |          |
|----------------------------------|----------|
| $V_{DS}$                         | 30V      |
| $I_D$ (at $V_{GS}=10V$ )         | 24A      |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 6.8mΩ  |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 10.5mΩ |

100% UIS Tested  
100%  $R_g$  Tested



### Applications

- DC/DC Converters in Computing
- Isolated DC/DC Converters in Telecom and Industrial
- See Note I



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AON7380               | DFN 3x3 EP   | Tape & Reel | 5000                   |

### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter  | Symbol         | Maximum    | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage                             | $V_{DS}$       | 30         | V     |
| Gate-Source Voltage                              | $V_{GS}$       | $\pm 20$   | V     |
| Continuous Drain Current <sup>G</sup>            | $I_D$          | 24         | A     |
| $T_C=100^\circ C$                                | $I_D$          | 24         |       |
| Pulsed Drain Current <sup>C</sup>                | $I_{DM}$       | 80         |       |
| Continuous Drain Current                         | $I_{DSM}$      | 20         | A     |
| $T_A=70^\circ C$                                 | $I_{DSM}$      | 15         |       |
| Avalanche Current <sup>C</sup>                   | $I_{AS}$       | 60         | A     |
| Avalanche energy $L=0.001\text{mH}$ <sup>C</sup> | $E_{AS}$       | 2          | mJ    |
| $V_{DS}$ Spike                                   | $V_{SPIKE}$    | 36         | V     |
| Power Dissipation <sup>B</sup>                   | $P_D$          | 24         | W     |
| $T_C=100^\circ C$                                | $P_D$          | 9.5        |       |
| Power Dissipation <sup>A</sup>                   | $P_{DSM}$      | 4.1        | W     |
| $T_A=70^\circ C$                                 | $P_{DSM}$      | 2.6        |       |
| Junction and Storage Temperature Range           | $T_J, T_{STG}$ | -55 to 150 | °C    |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 24  | 30  | °C/W  |
| Maximum Junction-to-Ambient <sup>A,B</sup> |                 | 47  | 60  | °C/W  |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 4.2 | 5.2 | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                             | Parameter  | Conditions  | Min | Typ | Max       | Units            |
|------------------------------------|--|---|-----|-----|-----------|------------------|
| <b>STATIC PARAMETERS</b>           |  |   |     |     |           |                  |
| $\text{BV}_{\text{DSS}}$           | Drain-Source Breakdown Voltage                     | $\text{ID}=250\mu\text{A}, \text{VGS}=0\text{V}$  | 30  |     |           | V                |
| $\text{I}_{\text{DSS}}$            | Zero Gate Voltage Drain Current                    | $\text{V}_{\text{DS}}=30\text{V}, \text{V}_{\text{GS}}=0\text{V}$<br>$\text{T}_J=55^\circ\text{C}$  |     | 1   | 5         | $\mu\text{A}$    |
| $\text{I}_{\text{GSS}}$            | Gate-Body leakage current                          | $\text{V}_{\text{DS}}=0\text{V}, \text{V}_{\text{GS}}=\pm 20\text{V}$                               |     |     | $\pm 100$ | nA               |
| $\text{V}_{\text{GS(th)}}$         | Gate Threshold Voltage                             | $\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_{\text{D}}=250\mu\text{A}$                     | 1.4 | 1.8 | 2.2       | V                |
| $\text{R}_{\text{DS(ON)}}$         | Static Drain-Source On-Resistance                  | $\text{V}_{\text{GS}}=10\text{V}, \text{I}_{\text{D}}=20\text{A}$<br>$\text{T}_J=125^\circ\text{C}$ |     | 5.6 | 6.8       | $\text{m}\Omega$ |
|                                    |  | $\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_{\text{D}}=20\text{A}$                                  |     | 8.1 | 9.8       | $\text{m}\Omega$ |
| $\text{g}_{\text{FS}}$             | Forward Transconductance                           | $\text{V}_{\text{DS}}=5\text{V}, \text{I}_{\text{D}}=20\text{A}$                                    |     | 40  |           | S                |
| $\text{V}_{\text{SD}}$             | Diode Forward Voltage                              | $\text{I}_{\text{S}}=1\text{A}, \text{V}_{\text{GS}}=0\text{V}$                                     |     | 0.7 | 1         | V                |
| $\text{I}_{\text{S}}$              | Maximum Body-Diode Continuous Current <sup>G</sup> |   |     |     | 24        | A                |
| <b>DYNAMIC PARAMETERS</b>          |  |   |     |     |           |                  |
| $\text{C}_{\text{iss}}$            | Input Capacitance                                  | $\text{V}_{\text{GS}}=0\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{f}=1\text{MHz}$             |     | 825 |           | pF               |
| $\text{C}_{\text{oss}}$            | Output Capacitance                                 |   |     | 335 |           | pF               |
| $\text{C}_{\text{rss}}$            | Reverse Transfer Capacitance                       |   |     | 40  |           | pF               |
| $\text{R}_{\text{g}}$              | Gate resistance                                    | $\text{f}=1\text{MHz}$  | 0.6 | 1.2 | 1.8       | $\Omega$         |
| <b>SWITCHING PARAMETERS</b>        |  |   |     |     |           |                  |
| $\text{Q}_{\text{g}}(10\text{V})$  | Total Gate Charge                                  | $\text{V}_{\text{GS}}=10\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{I}_{\text{D}}=20\text{A}$  |     | 13  | 25        | nC               |
| $\text{Q}_{\text{g}}(4.5\text{V})$ | Total Gate Charge                                  |   |     | 6.2 | 12        | nC               |
| $\text{Q}_{\text{gs}}$             | Gate Source Charge                                 |   |     | 2.2 |           | nC               |
| $\text{Q}_{\text{gd}}$             | Gate Drain Charge                                  |   |     | 2.6 |           | nC               |
| $\text{Q}_{\text{gs}}$             | Gate Source Charge                                 |   |     | 2.2 |           | nC               |
| $\text{Q}_{\text{gd}}$             | Gate Drain Charge                                  | $\text{V}_{\text{GS}}=4.5\text{V}, \text{V}_{\text{DS}}=15\text{V}, \text{I}_{\text{D}}=20\text{A}$ |     | 2.6 |           | nC               |
| $\text{t}_{\text{D(on)}}$          | Turn-On Delay Time                                 |   |     | 5   |           | ns               |
| $\text{t}_{\text{r}}$              | Turn-On Rise Time                                  |   |     | 3   |           | ns               |
| $\text{t}_{\text{D(off)}}$         | Turn-Off Delay Time                                |   |     | 20  |           | ns               |
| $\text{t}_{\text{f}}$              | Turn-Off Fall Time                                 |   |     | 3   |           | ns               |
| $\text{t}_{\text{rr}}$             | Body Diode Reverse Recovery Time                   | $\text{I}_{\text{F}}=20\text{A}, \text{di/dt}=500\text{A}/\mu\text{s}$                              |     | 11  |           | ns               |
| $\text{Q}_{\text{rr}}$             | Body Diode Reverse Recovery Charge                 | $\text{I}_{\text{F}}=20\text{A}, \text{di/dt}=500\text{A}/\mu\text{s}$                              |     | 17  |           | nC               |

A. The value of  $R_{\text{BJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{BJA}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{\text{J(MAX)}}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{\text{J(MAX)}}=150^\circ\text{C}$ .

D. The  $R_{\text{BJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{BJC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

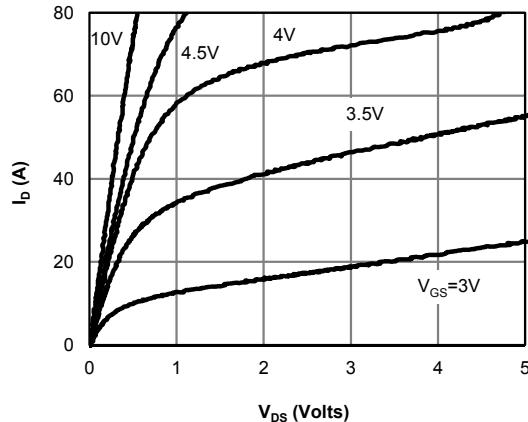
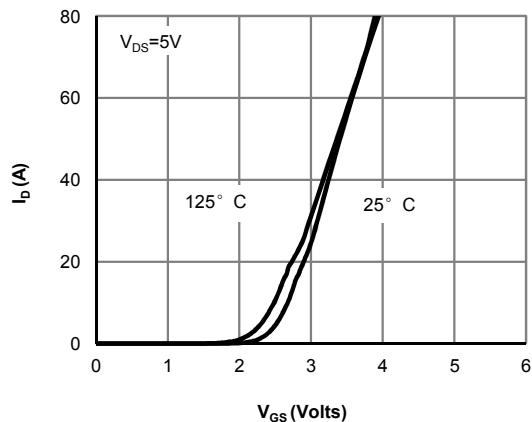
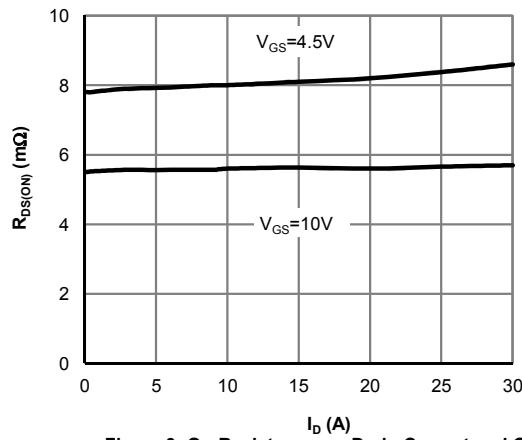
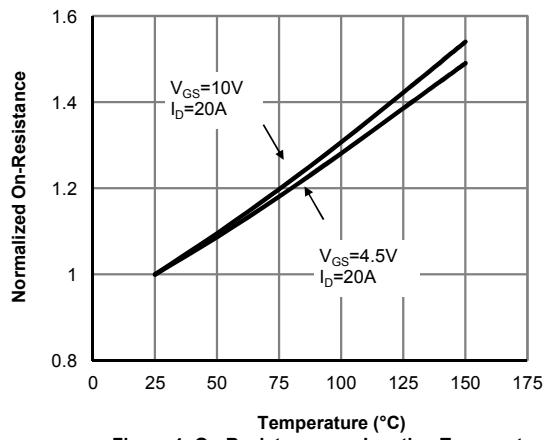
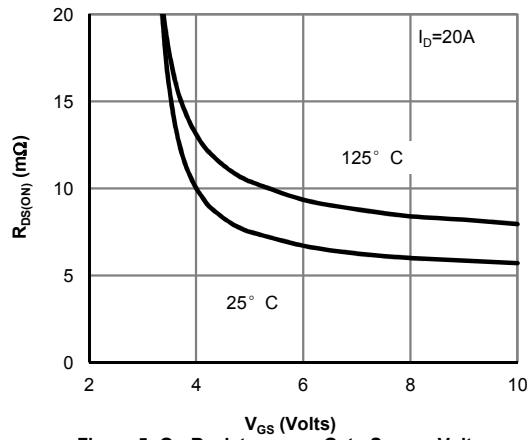
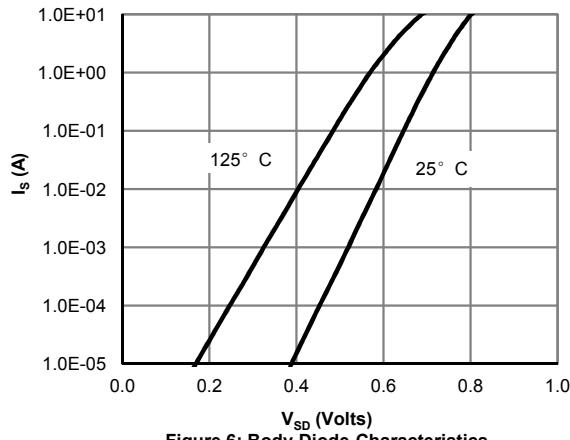
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{\text{J(MAX)}}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

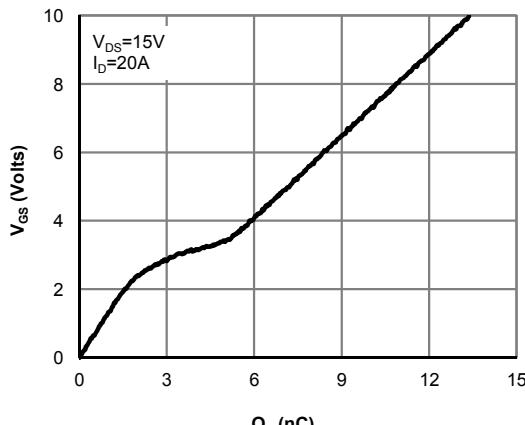
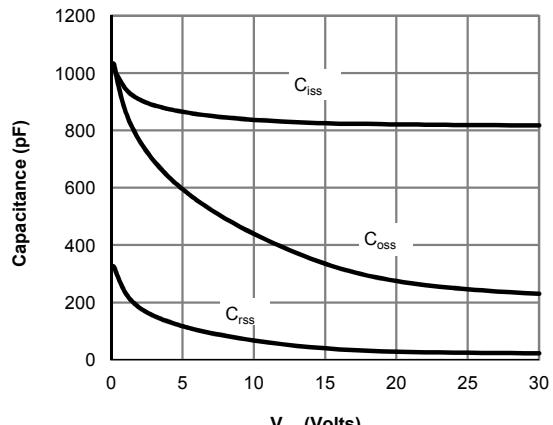
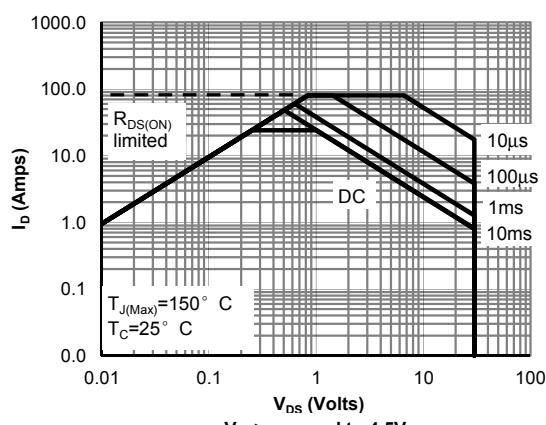
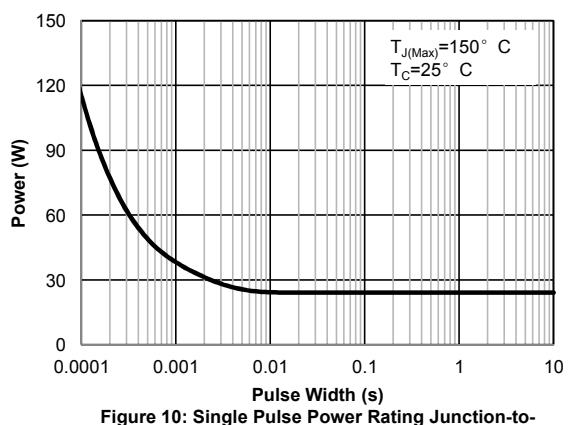
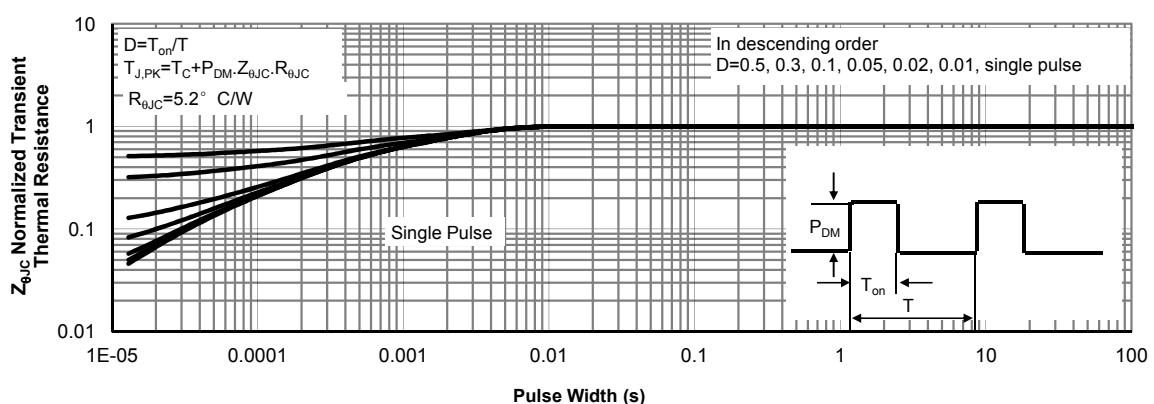
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

I. For application requiring slow >1ms turn-on/turn-off, please consult AOS FAE for proper product selection.

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**


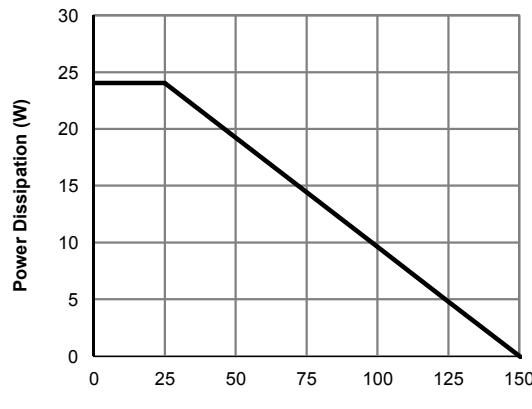
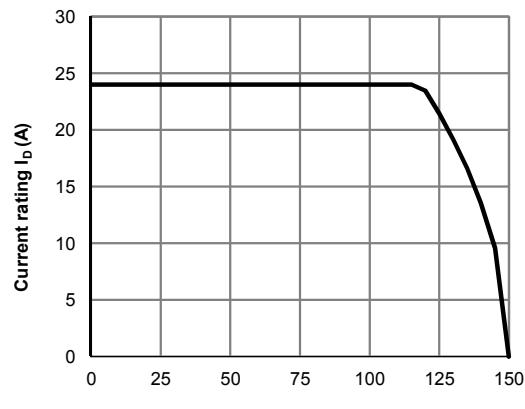
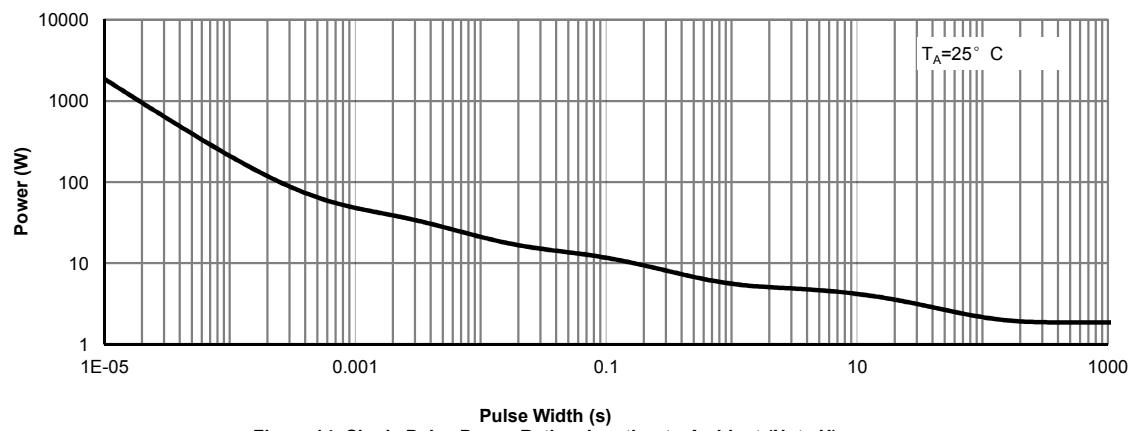
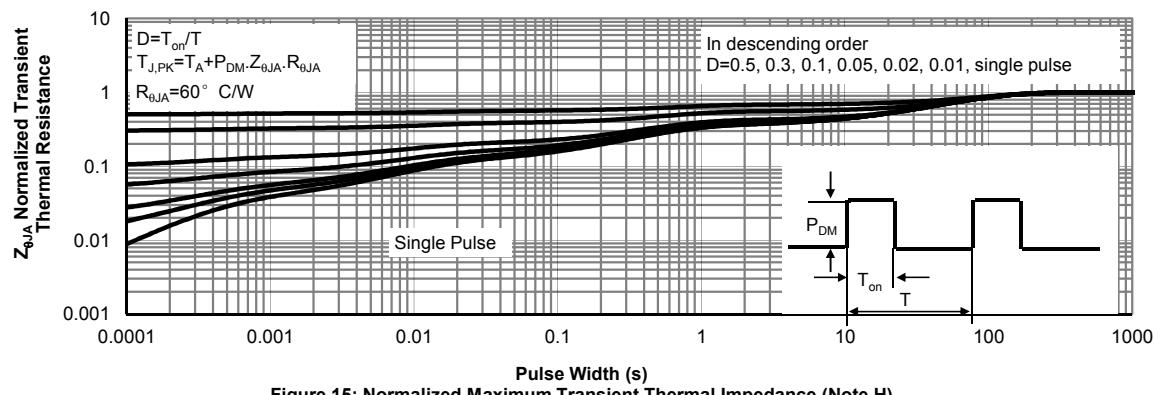
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

Figure A: Gate Charge Test Circuit &amp; Waveforms

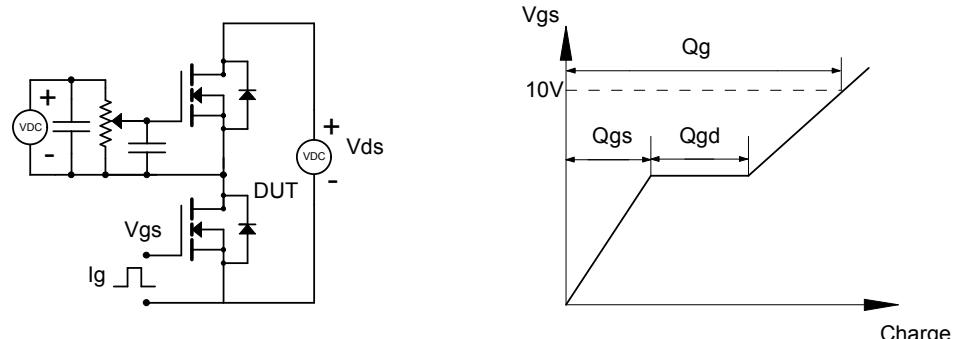


Figure B: Resistive Switching Test Circuit &amp; Waveforms

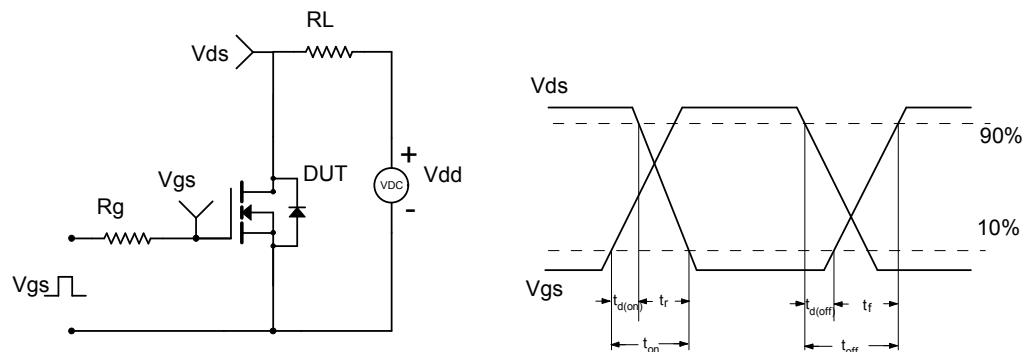


Figure C: Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms

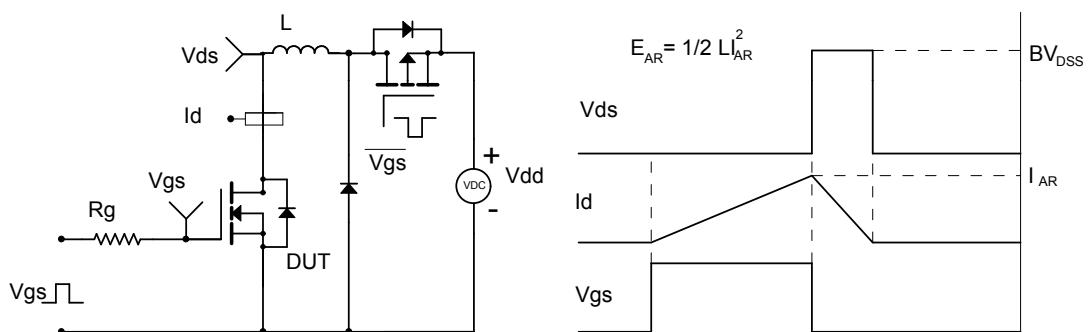


Figure D: Diode Recovery Test Circuit &amp; Waveforms

